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# Spin-orbit Torque in Structures with Magnetization-compensated MnGa/Co<sub>2</sub>MnSi bilayer

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We have systematically investigated the spin-orbit torque (SOT) induced effective magnetic field in a structure consisting of a Ta heavy metal layer and an antiferromagnetically coupled MnGa/Co<sub>2</sub>MnSi (CMS) bilayer around the magnetization compensation point by varying the CMS film thickness. The efficiency of SOT generation takes the maximum around the compensation point, and it is approximately 6 times as large compared with that in the devices with a MnGa single structure. The enhancement of SOT efficiency can be explained mainly by the reduction of saturation magnetic moment around the compensation point. Moreover, a significant enhancement of the effective spin Hall angle was observed around the compensation point because of the inversion of the magnetization configuration before and after the compensation point.

*Index Terms*—spin-orbit torque, synthetic antiferromagnetic structure, MnGa, Co<sub>2</sub>MnSi

## I. INTRODUCTION

Magnetic random access memory (MRAM) utilizing the spin-orbit torque (SOT) induced magnetization switching has attracted much interest as a next-generation non-volatile memory featuring high-speed switching and high writing endurance [1]-[8]. The synthetic antiferromagnetic (SAF) structure, in which two or more thin ferromagnetic layers are antiferromagnetically coupled, is promising for a recording layer of SOT-MRAM because of low stray magnetic field and high thermal stability. Moreover, high SOT efficiency is also expected for the SAF structure due to low saturation magnetic moment because the efficiency of SOT generation is inversely proportional to the magnetization of the ferromagnetic layer [9].

A Mn<sub>x</sub>Ga<sub>1-x</sub> (MnGa)/Co<sub>2</sub>MnSi (CMS) bilayer is one of the candidates for the above-mentioned ferromagnetic electrodes due to the following features. MnGa and CMS layers are antiferromagnetically coupled to each other [10], which results in forming the SAF structure. A MnGa exhibits relatively large perpendicular magnetic anisotropy (PMA) [11]-[13], and there have been several reports on MnGa-based perpendicular magnetic tunnel junctions (p-MTJs) [14]. SOT-induced magnetization switching in ultrathin MnGa structures [15]-[20] have also been reported. On the other hand, a CMS is theoretically predicted to show a half-metallic nature [21]-[23], and high TMR ratios have been experimentally demonstrated in CMS-based MTJs [24]-[28]. Thus, a p-MTJ with MnGa/CMS free layer is expected to exhibit high TMR ratio and high thermal stability.

Recently, we have reported the SOT magnetization switching with low switching current density in a MnGa/CMS bilayer

compared to a MnGa single layer [29]. However, the magnetization was not compensated in the previous MnGa/CMS bilayer. To take full advantage of the SAF structure, the magnetization of the bilayer should be compensated. Although Li et al., realized magnetization compensation in a MnGa/CMS bilayer by changing the temperature, and reported the SOT switching characteristics [30], the effect of magnetization compensation on the SOT properties is still not fully understood. Given these backgrounds, the purpose of this study is to clarify the efficiency of SOT generation near the magnetization-compensation point in a MnGa/CMS bilayer structure with a Ta acting as the source of SOT. For this purpose, we systematically controlled the magnetization in MnGa/CMS bilayers by varying the CMS thicknesses ( $t_{\text{CMS}}$ ) on the same substrate and investigated the  $t_{\text{CMS}}$ -dependence of SOT-induced effective magnetic field.

## II. EXPERIMENTAL METHOD

A layer structure consisting of (from the substrate side) MgO buffer (10)/Ni<sub>1.1</sub>Al<sub>1</sub> (NiAl) buffer (5)/MnGa (2.5)/CMS (0–1.7)/Ta (5)/MgO cap (2) was grown on a (001) MgO single-crystalline substrate [Fig. 1(a)]. The numbers in parentheses are nominal thicknesses in nanometers. A 2.5-nm-thick MnGa was grown on a NiAl buffer layer by molecular-beam epitaxy at 200°C and was annealed at 300°C. Then, a CMS wedged layer was grown by rf magnetron sputtering at room temperature and then was annealed at 400°C. The thickness of CMS was varied from 0 to 1.7 nm on the same substrate by using a sliding shutter to realize the magnetization compensation. Finally, a 5-nm thick Ta was deposited by dc sputtering at room temperature as an SOT spin source. The composition of MnGa was Mn<sub>1.8</sub>Ga<sub>1</sub> from inductively coupled plasma (ICP) optical emission spectroscopy measurements. In order to investigate the influence of NiAl buffer on the SOT characteristics, a 2.5-nm-thick MnGa single layer without Ta was also grown. The structural and magnetic properties of MnGa/CMS bilayer were

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characterized by reflection high-energy electron diffraction (RHEED) observations and magneto-optical Kerr effect (MOKE) measurement. The layer structure was processed into Hall devices with a 5- $\mu\text{m}$ -wide channel by photolithography and Ar ion milling. We measured the transverse resistance  $R_{yx}$  to investigate the SOT-induced effective magnetic field at room temperature. A schematic of the measurement setup with a definition of the Cartesian coordinate system is shown in Fig. 1(b).

### III. RESULT AND DISCUSSION

#### A. Structural and magnetic properties

Fig. 1(c) shows RHEED patterns of MnGa and CMS layers under the electron beam azimuth along MgO[100] direction. We observed clear streak patterns for MnGa and CMS, indicating the epitaxial growth of both MnGa and CMS. Moreover, we observed clear  $11^*$  superlattice lines of the CMS after 400°C annealing, suggesting that the CMS film was L2<sub>1</sub>-ordered.

Fig. 2(a) shows the polar MOKE signals of MnGa/CMS bilayer measured at room temperature for various  $t_{\text{CMS}}$  ranging from 0 to 1.55 nm as a function of  $\mu_0 H_z$ , where  $\mu_0$  is the permeability of vacuum and  $H_z$  is the out-of-plane magnetic field. Clear hysteresis loops reflecting the PMA of both MnGa and CMS were observed for  $t_{\text{CMS}} \leq 1.15$  nm except for  $t_{\text{CMS}} = 0.45$  nm. The amplitude of the hysteresis loops decreased and the coercive field increased as increasing  $t_{\text{CMS}}$  from 0 to 0.4 nm, indicating that the MnGa and CMS are antiferromagnetically coupled to each other. For  $t_{\text{CMS}} > 0.55$  nm, the polarity of the hysteresis loops changed. This indicates that the magnetic moment of CMS becomes larger than that of MnGa, and the MnGa is magnetized antiparallel to the magnetic field. Thus, the magnetization compensation is realized at  $t_{\text{CMS}} \approx 0.45$  nm. The coercive field decreased with increasing  $t_{\text{CMS}}$  from 0.55 nm to 1.55 nm because the influence of CMS favoring the in-plane magnetic anisotropy becomes stronger in structures with thick CMS.

Fig. 2(b) shows  $R_{yx}$  as a function of  $\mu_0 H_z$  for MnGa/CMS bilayers with various  $t_{\text{CMS}}$  ranging from 0 to 1.0 nm. The  $R_{yx}$  and the MOKE signals show similar hysteresis loops. Slight differences in coercive field between  $R_{yx}$  and MOKE signals are probably due to the influence of Hall-bar processing and/or Joule heating by current used for measurement of  $R_{yx}$ . Since MOKE signals reflect magnetization of MnGa for MnGa/CMS bilayers with  $t_{\text{CMS}} = 0 - 1.0$  nm from magnetization measurement,  $R_{yx}$  for the MnGa/CMS bilayer is dominated by the anomalous Hall signal arising from the MnGa, and the magnetization direction of MnGa is detected from the values of  $R_{yx}$ .

#### B. SOT-induced effective magnetic field

We evaluated the effective magnetic field  $H_{\text{eff}}$  induced by the SOT acting on the magnetization in domain walls (DWs) created during magnetization reversal to clarify the SOT efficiency in the antiferromagnetically coupled MnGa/CMS

bilayer [31]. To do this, we measured the shift of  $R_{yx} - \mu_0 H_z$  curves under in-plane magnetic field  $H_x$  along current direction. Fig. 3(a) shows normalized  $R_{yx}$  as a function of  $\mu_0 H_z$  under  $\mu_0 H_x = \pm 300$  mT and dc current  $I = \pm 12$  mA for the device with  $t_{\text{CMS}} = 0.6$  nm. When  $I$  and  $H_x$  are parallel (antiparallel), the center of the hysteresis loop was shifted in the negative (positive)  $H_z$  direction. These results can be explained as follows. The magnetization  $\mathbf{m}$  in MnGa/CMS bilayer feels the effective field along  $\mathbf{m} \times \mathbf{s}_y$  direction due to the spin current generated from the spin Hall effect in Ta, where  $\mathbf{s}_y$  is electron spin which points along  $y$ -axis direction. When  $\mathbf{m}$  in the DWs points along  $x$ -axis direction by  $H_x$  application, the effective field along  $z$ -axis direction is generated, which assists or hinders the DW motion, resulting in the shift of hysteresis loop. Thus, the shift amount of the hysteresis loop with respect to the center position corresponds to  $\mu_0 H_{\text{eff}}$  acting on DWs. As shown in Fig. 3(b), the value of  $\mu_0 H_{\text{eff}}$  increased almost linearly with increasing  $|\mu_0 H_x|$  and saturated at large  $|\mu_0 H_x|$ . This saturation is due to the magnetization in the DWs being magnetized in the  $x$ -axis direction by sufficient  $\mu_0 H_x$ .

We carried out similar measurement on the devices with  $t_{\text{CMS}}$  ranging from 0 to 1.0 nm and obtained saturated values of  $\mu_0 H_{\text{eff}}$ . We divided the saturated value  $\mu_0 H_{\text{eff}}^*$  by current density in Ta ( $J_{\text{Ta}}$ ), which is a measure of SOT efficiency, and plotted them as a function of  $t_{\text{CMS}}$  in Fig. 4(a). Interestingly a significant increase of  $\mu_0 H_{\text{eff}}^*/J_{\text{Ta}}$  was observed near the compensation point, and it took the maximum in the device with  $t_{\text{CMS}} = 0.6$  nm, which is approximately 6 times as large compared with that in the device with  $t_{\text{CMS}} = 0$ .

Now we will discuss the origin of the variation of  $\mu_0 H_{\text{eff}}^*/J_{\text{Ta}}$  with respect to  $t_{\text{CMS}}$ . According to the macro-spin model, the value of  $\mu_0 H_{\text{eff}}^*/J_{\text{Ta}}$  is given by [9]

$$\left| \frac{\mu_0 H_{\text{eff}}^*}{J_{\text{Ta}}} \right| = \frac{\pi \hbar \theta_{\text{SH}}}{2 2em_s}, \quad (1)$$

where  $\hbar$  is the Dirac constant,  $e$  is the elementary charge,  $\theta_{\text{SH}}$  is the effective spin Hall angle, and  $m_s$  is the saturation magnetic moment per area. Fig. 4(b) and (c) show  $m_s$  and  $\theta_{\text{SH}}$  as a function of  $t_{\text{CMS}}$ . The values of  $m_s$  were calculated from the relation given by

$$m_s = |M_s^{(\text{MnGa})} \cdot t_{\text{MnGa}} - M_s^{(\text{CMS})} \cdot t_{\text{CMS}}|, \quad (2)$$

where  $t_{\text{MnGa}} (= 2.5 \text{ nm})$  is the thickness of MnGa,  $M_s^{(\text{MnGa})} (\approx 1.6 \times 10^5 \text{ A/m})$  and  $M_s^{(\text{CMS})} (\approx 8.0 \times 10^5 \text{ A/m})$  are the saturation magnetization of MnGa and CMS, respectively, whose values were obtained by measuring the magnetization of a 2-nm-thick MnGa single layer and a MnGa(2)/CMS(1) bilayer fabricated under the same growth conditions [29]. Substituting  $m_s$  and  $\mu_0 H_{\text{eff}}^*/J_{\text{Ta}}$  values into (1), we calculated  $\theta_{\text{SH}}$  for each  $t_{\text{CMS}}$ . The  $m_s$  was modulated by approximately 10 times at  $0 \leq t_{\text{CMS}} \leq 1$  nm, whereas the  $\theta_{\text{SH}}$  is modulated by approximately 4 times. Therefore, the value of  $\mu_0 H_{\text{eff}}^*/J_{\text{Ta}}$  depends more dominantly on the change of  $m_s$  than that of  $\theta_{\text{SH}}$ .

Finally, we will discuss on the origin of the variation of  $\theta_{\text{SH}}$  with respect to  $t_{\text{CMS}}$ . We obtained  $\theta_{\text{SH}} = 0.009$  at  $t_{\text{CMS}} = 0$  [see Fig. 4(c)]. This value is smaller than the previously reported values for the Ta layer (0.12 - 0.15 [3]). This is possibly because the MnGa is relatively thick, in which case the SOT becomes

weak as the distance from the Ta/MnGa interface increases. Another reason is the influence of the spin current from NiAl layer. To confirm this, we measured the effective field for a 2.5-nm-thick MnGa single layer without Ta and obtained  $\theta_{SH} \approx 0.001$  (*not shown*). This indicates that the NiAl buffer also generates weak spin current. Since the sign of  $\theta_{SH}$  for Ta and that for NiAl is the same, the SOT induced by Ta and that by NiAl competes each other, resulting in the reduction of effective  $\theta_{SH}$ . The  $\theta_{SH}$  further decreased with increasing  $t_{CMS}$  from 0 to 0.42 nm because the insertion of CMS further reduces the SOT acting on the MnGa, which dominates total magnetic moment of the MnGa/CMS bilayer. However, the  $\theta_{SH}$  increased rapidly up to 0.02 near the compensation point. This variation can be due to the inversion of the magnetization configuration before and after the compensation point, where total magnetic moment in MnGa (CMS) is dominant in MnGa/CMS bilayer with  $t_{CMS} < 0.45$  nm ( $> 0.45$  nm) [see Fig. 2(a)]. After the compensation point ( $t_{CMS} > 0.45$  nm) the SOT from Ta acting on the CMS and that from NiAl acting on the MnGa cooperate to switch the MnGa/CMS, resulting in the increase of effective  $\theta_{SH}$ . However, more exact models beyond the macro-spin model are necessary to fully understand the physical origins of complicated feature for  $t_{CMS}$ -dependence of  $\theta_{SH}$ .

#### IV. CONCLUSION

We investigated the SOT-induced effective magnetic field in a structure consisting of Ta heavy metal layer and an antiferromagnetically coupled MnGa/CMS bilayer around the magnetization compensation point and found that the strength of the effective magnetic field was enhanced near the magnetization-compensation point mainly because of the reduction of total magnetic moment of MnGa/CMS. These results contribute to understanding of SOT in antiferromagnetically coupled bilayers and suggest the potential of realizing efficient SOT magnetization switching.

#### ACKNOWLEDGMENT

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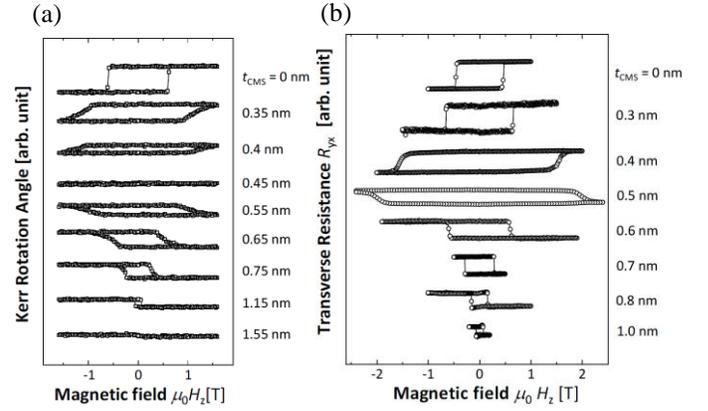


Fig. 2. (a) MOKE signals and (b) transverse resistance  $R_{yx}$  as a function of  $\mu_0 H_z$  for  $\text{MnGa}/\text{CMS}$  bilayers with various  $t_{\text{CMS}}$ . The  $\text{MnGa}$  and  $\text{CMS}$  are antiferromagnetically coupled to each other with clear PMA at  $t_{\text{CMS}} < 1.55$  nm. The magnetization compensation was realized at  $t_{\text{CMS}} \approx 0.45$  nm.

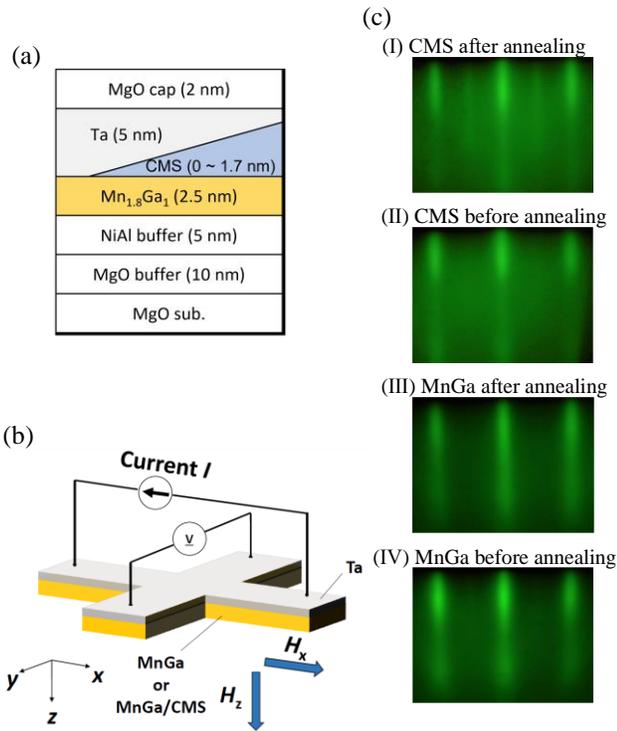


Fig. 1. Schematics of (a) a layer structure and (b) a typical Hall device with a 5- $\mu\text{m}$ -wide channel with a definition of the Cartesian coordinate system. The transverse resistance  $R_{yx}$  was measured with an in-plane dc current  $I$  under application of in-plane magnetic field ( $H_x$ ) and out-of-plane magnetic fields ( $H_z$ ). (c) (I) - (IV) RHEED patterns of  $\text{MnGa}$  and  $\text{CMS}$  before and after annealing. The electron beam azimuth was along  $\text{MgO}[100]$  direction. Clear streak patterns indicate the epitaxial growth of both  $\text{MnGa}$  and  $\text{CMS}$ .

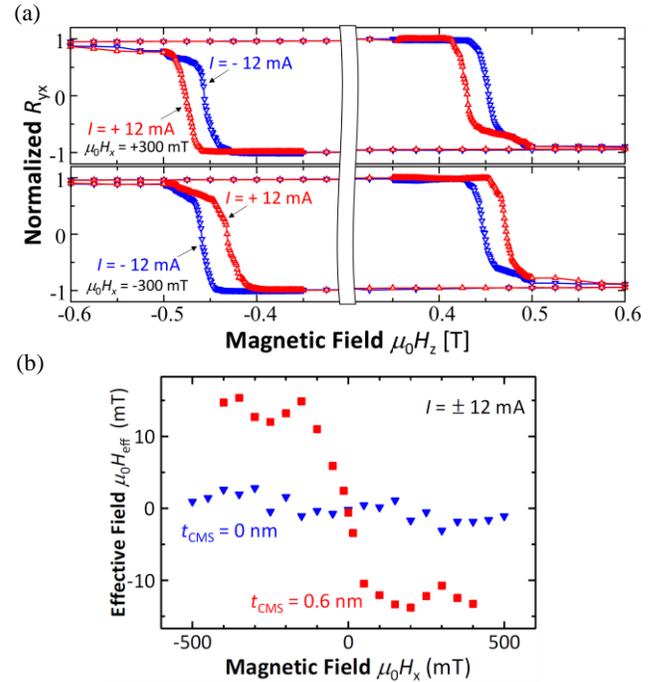


Fig. 3. (a) Normalized  $R_{yx}$  measured with  $I = \pm 12$  mA as a function of  $\mu_0 H_z$  under  $\mu_0 H_x = \pm 300$  mT for a device with  $t_{\text{CMS}} = 0.6$  nm. The difference of coercive fields between  $R_{yx} - \mu_0 H_z$  loop with positive  $I$  and that with negative  $I$  corresponds to  $2\mu_0 H_{\text{eff}}$ . (b)  $\mu_0 H_{\text{eff}}$  as a function  $\mu_0 H_x$  for the devices with  $t_{\text{CMS}} = 0$  and  $0.6$  nm. Approximately 6-times as large  $H_{\text{eff}}$  was observed in the device with  $t_{\text{CMS}} = 0.6$  nm compared with that in the device with  $t_{\text{CMS}} = 0$ .

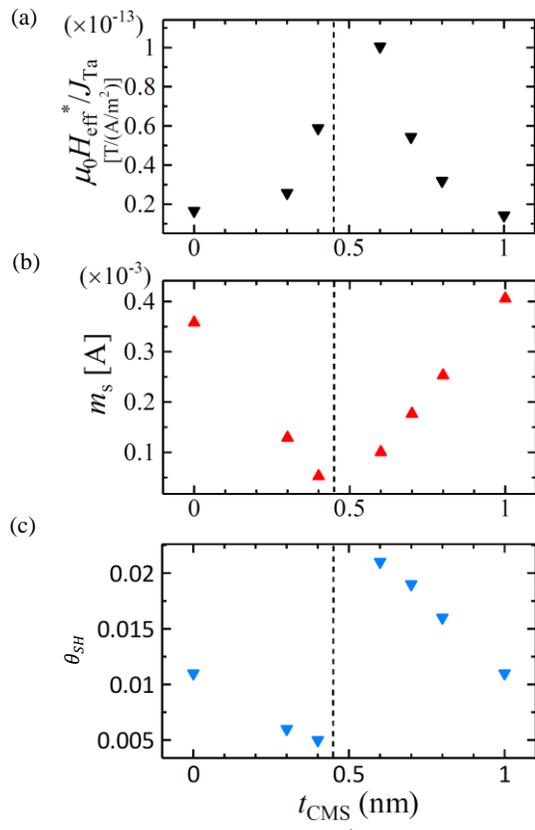


Fig. 4. (a) SOT efficiency  $\mu_0 H_{\text{eff}}^* / J_{\text{Ta}}$ , (b) calculated saturation magnetic moment  $m_s$ , and (c) effective spin Hall angle  $\theta_{\text{SH}}$  calculated from (1), as a function of  $t_{\text{CMS}}$ . The black dotted line in each figure indicates the magnetization compensation point.